Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/604,289	CHEN ET AL.
Examiner	Art Unit
TUAN A. PHAM	2618

SEARCHED					
Class	Subclass	Date	Examiner		
455	550.1	9/19/2006	РНАМ		
	478.8				
	90.3				
	575.1				
	575.3				
	575.4				
	575.6	9/19/2006	PHAM		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
	ce search tout	9/19/2006	РНАМ	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
Consulted with: Sonny Trinh	9/20/2006	РНАМ	
Interference search	9/19/2006	РНАМ	